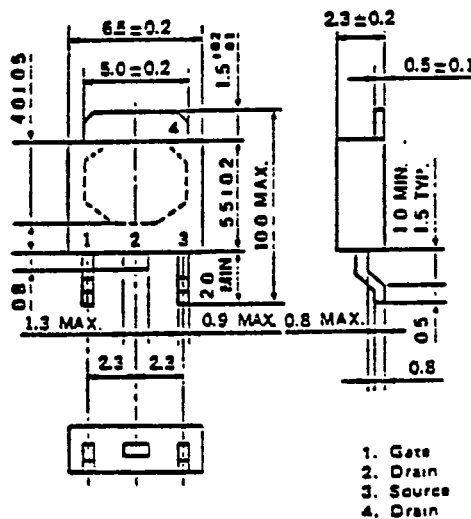




MOS FIELD EFFECT POWER TRANSISTOR 2SJ128-Z

FAST SWITCHING P-CHANNEL SILICON POWER MOS FET INDUSTRIAL USE

PACKAGE DIMENSIONS In millimeters



FEATURES

- Suitable for switching power supplies, actuator controls, and pulse circuits.
- Low $R_{DS(on)}$
- No second breakdown
- 4 V Gate Drive - Logic level -
- Designed for Hybrid Integrated Circuits

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Drain to Source Voltage	V_{DS}	-100	V
Gate to Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	$I_{D(DC)}$	± 2	A
Peak Drain Current	$I_{D(pulse)}$	± 8	A
Total Power Dissipation	P_T^{**}	20	W
Total Power Dissipation at 25°C Ambient Temperature	P_T^{***}	2.0	W
Channel Temperature	T_{ch}	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

* PW $\leq 300 \mu\text{s}$, Duty Cycle $\leq 10\%$

** $T_c = 25^\circ\text{C}$

*** Mounted on ceramic substrate of $2.5 \text{ cm}^2 \times 0.7 \text{ mm}$

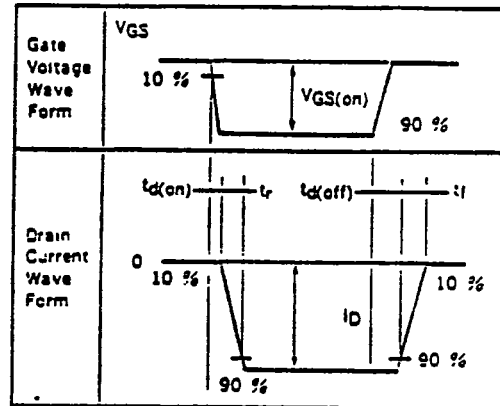
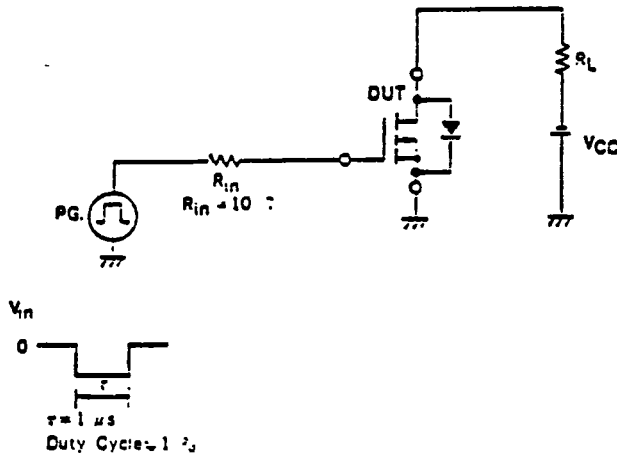
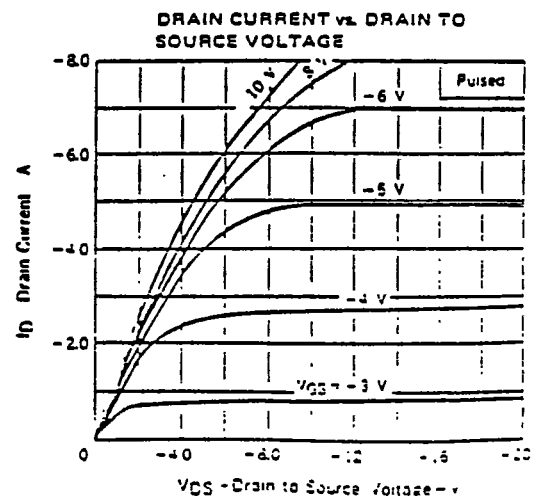
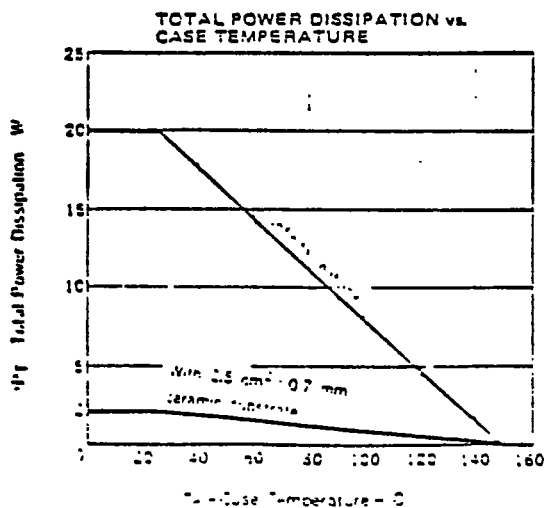
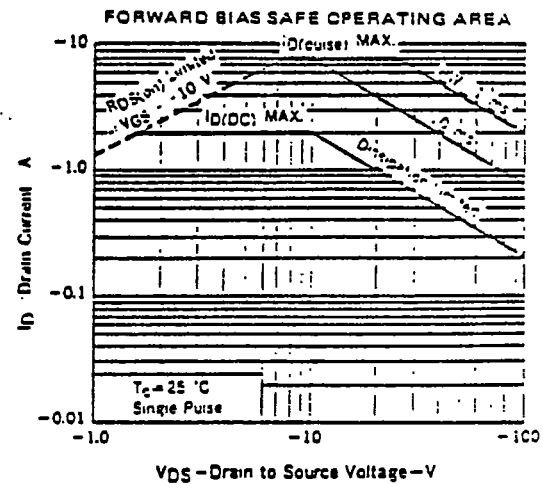
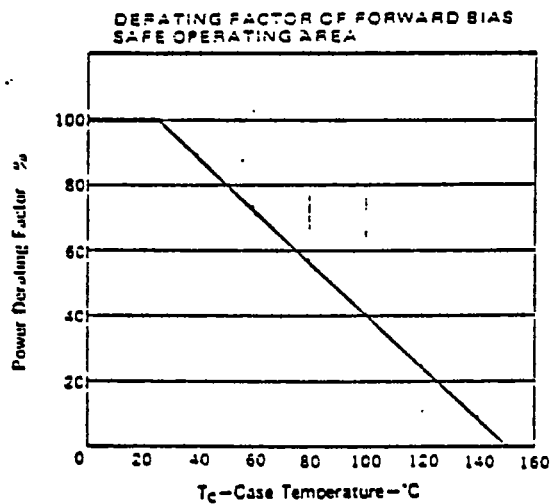
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Drain Leakage Current	I_{DSS}			-10	μA	$V_{DS} = -100 \text{ V}, V_{GS} = 0$
Gate to Source Leakage Current	I_{GSS}			± 100	nA	$V_{GS} = -20 \text{ V}, V_{DS} = 0$
Gate to Source Cutoff Voltage	$V_{GS(off)}$	-1.0		-3.0	V	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$
Forward Transfer Admittance	$ y_{fs} $	1.0			S	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ A}$
Drain to Source On-State Resistance	$R_{DS(on)}$		0.8	1.0	Ω	$V_{GS} = -10 \text{ V}, I_D = -1 \text{ A}$
Drain to Source On-State Resistance	$R_{DS(on)}$		1.1	1.5	Ω	$V_{GS} = -4 \text{ V}, I_D = -0.8 \text{ A}$
Input Capacitance	C_{iss}		1000		pF	$V_{DS} = -10 \text{ V}, V_{GS} = 0$ $f = 1 \text{ MHz}$
Output Capacitance	C_{oss}		200		pF	
Reverse Transfer Capacitance	C_{rfs}		25		pF	
Turn-On Delay Time	$t_{d(on)}$		30		ns	$I_D = -1 \text{ A}, V_{CC} = -50 \text{ V}$ $V_{GS(on)} = -10 \text{ V}$ $R_L = 10 \Omega$ $R_{in} = 10 \Omega$
Rise Time	t_r		30		ns	
Turn-Off Delay Time	$t_{d(off)}$		110		ns	
Fall Time	t_f		40		ns	

2SJ128-Z

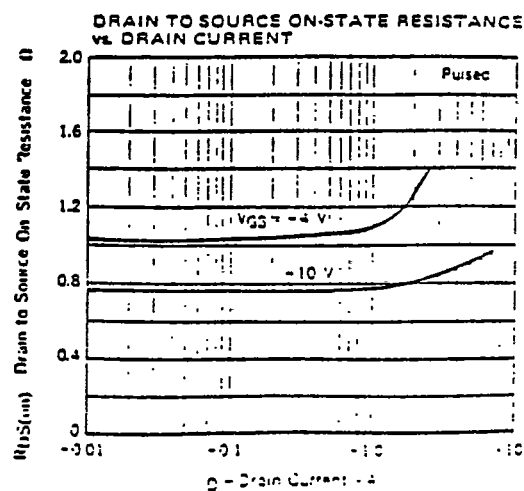
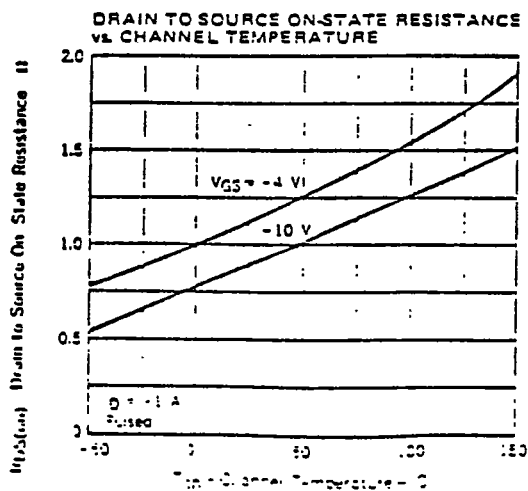
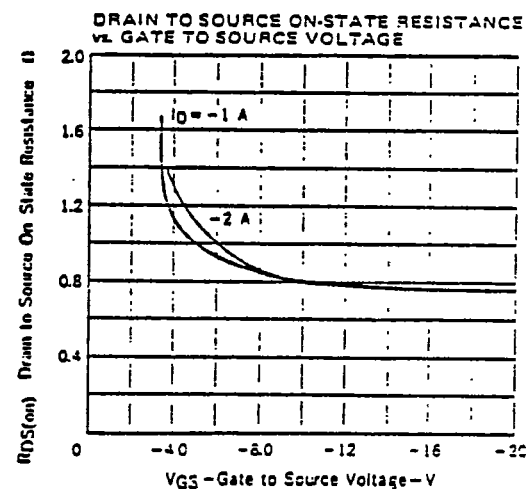
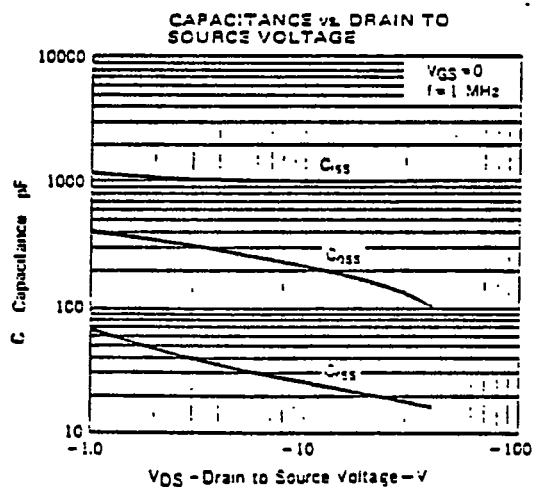
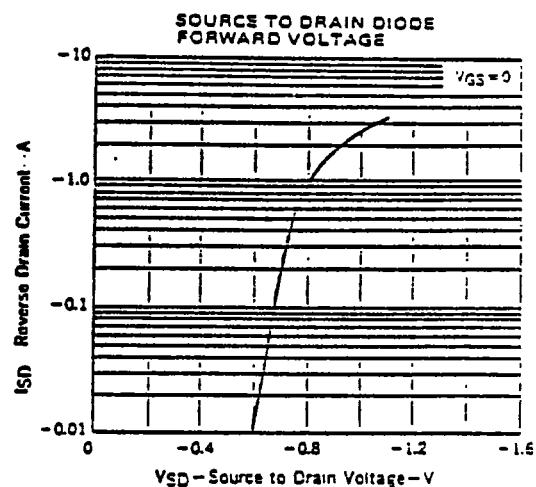
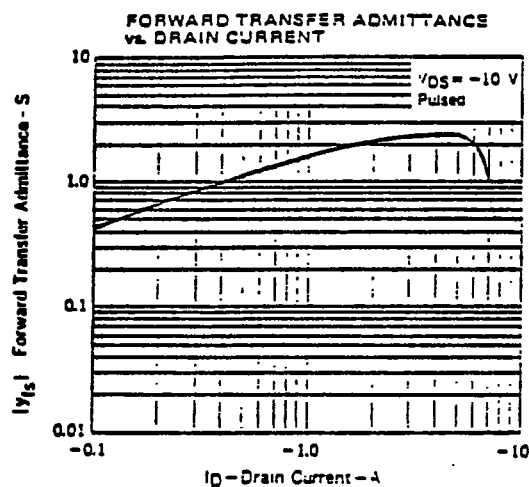
NEC ELECTRON DEVICE

TURN-ON AND TURN-OFF TIME TEST CIRCUIT

TYPICAL CHARACTERISTICS ($T_a = 25^\circ C$)

NEC ELECTRON DEVICE

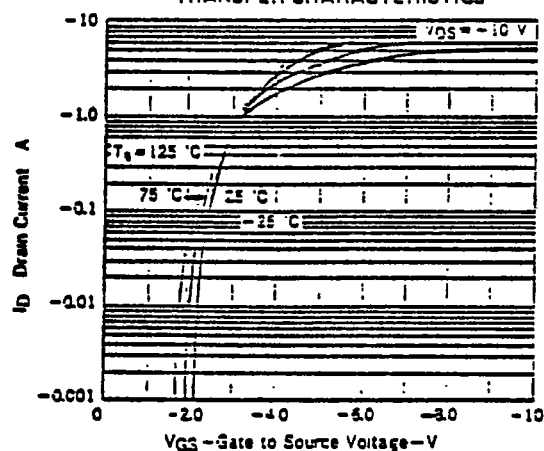
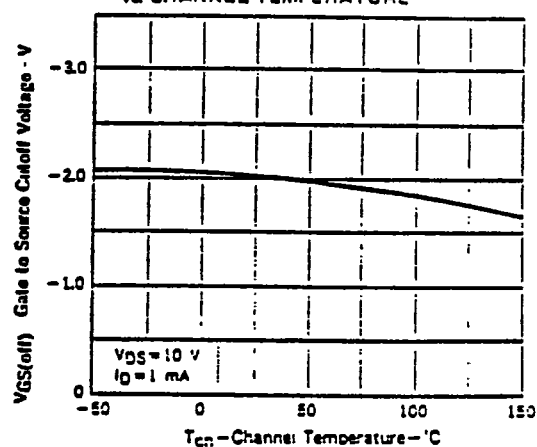
2SJ128-Z



2SJ128-Z

NEC ELECTRON DEVICE

TRANSFER CHARACTERISTICS

GATE TO SOURCE CUTOFF VOLTAGE
vs. CHANNEL TEMPERATURE

SWITCHING TIME vs. DRAIN CURRENT

